


<b>Search Notes</b>  	<b>Application/Control No.</b>  10673732	<b>Applicant(s)/Patent Under Reexamination</b>  PARENTE ET AL.
	<b>Examiner</b>  Yeh, Eueng-nan	<b>Art Unit</b>  2609

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Text search (see search history printouts)	2007/01/16	ey
IEEE Xplore search (see search history printout)	2006/12/26	ey
FoodScienceCentral search (see search history printout)	2007/01/10	ey
WebEbscohost search (see search history printouts)	2006/12/26	ey
ProquestUmi search (see search history printouts)	2006/12/26	ey
PALM Intranet search (see search history printouts)	2006/12/26	ey
STIC search (see search history printouts)	2007/01/09	ey
STIC search (see search history printouts)	2006/12/14	ey

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>